ALPHA & OMEGA SEMICONDUCTOR

AOB66216L

120V N-Channel AlphaSGT™

General Description

- Trench Power MOSFET technology
- Combined of low $R_{DS(ON)}$ and wide Safe Operating Area (SOA)
- Higher in-rush current enabled for faster start-up and shorter down time
- RoHS 2.0 and Halogen-Free Compliant
- Tj=175C Rated

Applications

- Load switch
- BMS
- Motor

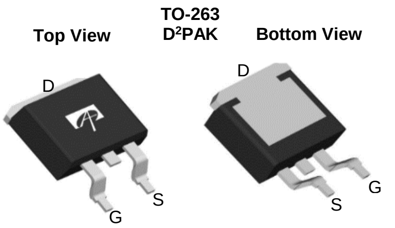
Product Summary

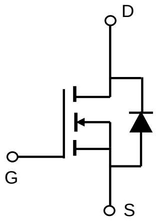
V_{DS}	120V
I_D (at V_{GS}=10V)	120A
$R_{DS(ON)}$ (at V_{GS}=10V)	< 4.8mΩ
$R_{DS(ON)}$ (at V_{GS}=6V)	< 6.9mΩ

100% UIS Tested
100% Rg Tested

Max Tj=175°C

Green Product





Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOB66216L	TO-263	Tape & Reel	800

Absolute Maximum Ratings T_A=25°C unless otherwise noted

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V_{DS}	120	V
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain Current [G]	T_C=25°C	I_D	120	A
	T_C=100°C		120	
Pulsed Drain Current [C]		I_{DM}	480	
Continuous Drain Current	T_A=25°C	I_{DSM}	27	A
	T_A=70°C		23	
Avalanche Current [C]		I_{AS}	100	A
Avalanche energy	L=0.1mH [C]	E_{AS}	500	mJ
Power Dissipation [B]	T_C=25°C	P_D	375	W
	T_C=100°C		187	
Power Dissipation [A]	T_A=25°C	P_{DSM}	10	W
	T_A=70°C		7	
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 175	°C

Thermal Characteristics

Parameter		Symbol	Typ	Max	Units
Maximum Junction-to-Ambient [A]	t ≤ 10s	$R_{\theta JA}$	12	15	°C/W
Maximum Junction-to-Ambient [A D]	Steady-State		50	60	°C/W
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.26	0.4	°C/W

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	I_D=250µA, V_{GS}=0V	120			V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=120V, V_{GS}=0V			1	µA
		T_J=55°C			5	
I_{GSS}	Gate-Body leakage current	V_{DS}=0V, V_{GS}=±20V			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=$V_{GS,}$ I_D=250µA	2	2.5	3	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS}=10V, I_D=20A		4	4.8	mΩ
		T_J=125°C		7.7	9.3	
		V_{GS}=6V, I_D=20A		5.5	6.9	mΩ
g_{FS}	Forward Transconductance	V_{DS}=5V, I_D=20A		45		S
V_{SD}	Diode Forward Voltage	I_S=1A, V_{GS}=0V		0.7	1	V
I_S	Maximum Body-Diode Continuous Current [G]				120	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=75V, f=1MHz		16700		pF
C_{oss}	Output Capacitance			720		pF
C_{rss}	Reverse Transfer Capacitance			17		pF
R_g	Gate resistance	f=1MHz	1	2	3	Ω
SWITCHING PARAMETERS						
Q_g(10V)	Total Gate Charge	V_{GS}=10V, V_{DS}=75V, I_D=20A		190	270	nC
Q_{gs}	Gate Source Charge			55		nC
Q_{gd}	Gate Drain Charge			15		nC
Q_{oss}	Output Charge	V_{GS}=0V, V_{DS}=75V		260		nC
$t_{D(on)}$	Turn-On DelayTime	V_{GS}=10V, V_{DS}=75V, R_L=3.75Ω, R_{GEN}=3Ω		33		ns
t_r	Turn-On Rise Time			28		ns
$t_{D(off)}$	Turn-Off DelayTime			128		ns
t_f	Turn-Off Fall Time			35		ns
t_{rr}	Body Diode Reverse Recovery Time	I_F=20A, di/dt=500A/µs		84		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I_F=20A, di/dt=500A/µs		1.18		µC

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R $_{\theta JA}$ t≤ 10s and the maximum allowed junction temperature of 175° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.
B. The power dissipation P_D is based on $T_{J(MAX)}$=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
C. Single pulse width limited by junction temperature $T_{J(MAX)}$=175° C.
D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case R $_{\theta JC}$ and case to ambient.
E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$=175° C. The SOA curve provides a single pulse rating.
G. The maximum current rating is package limited.
H. These tests are performed with the device mounted on 1 in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

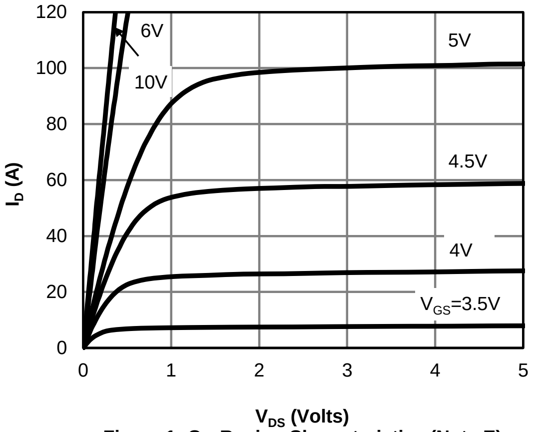


Figure 1: On-Region Characteristics (Note E)

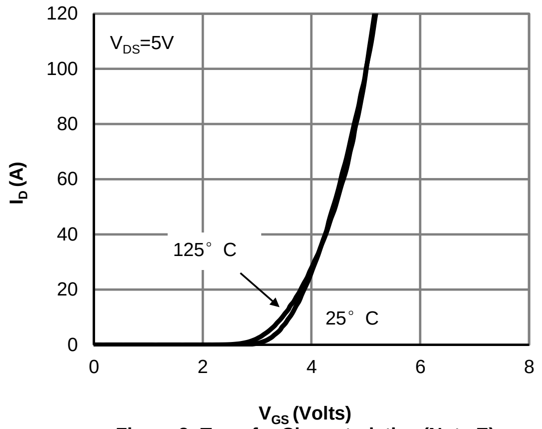


Figure 2: Transfer Characteristics (Note E)

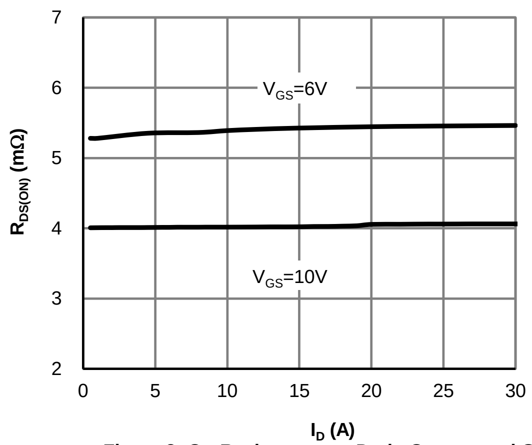


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

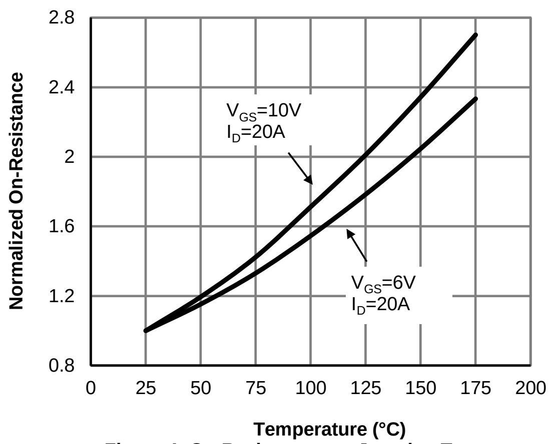


Figure 4: On-Resistance vs. Junction Temperature (Note E)

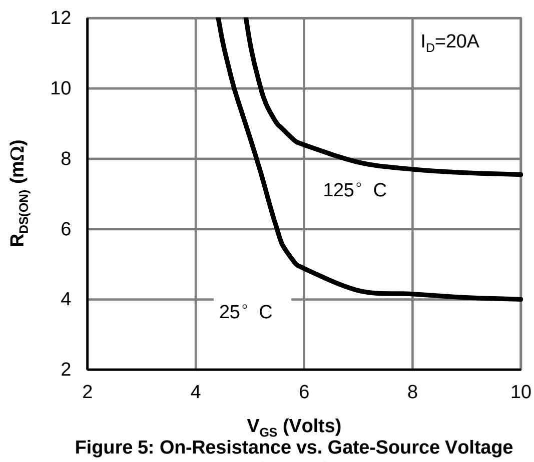


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

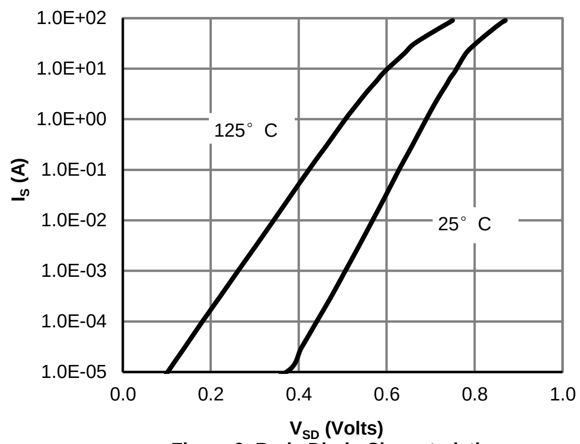


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

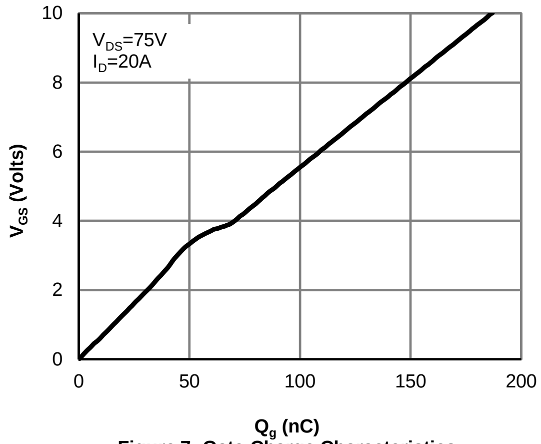


Figure 7: Gate-Charge Characteristics

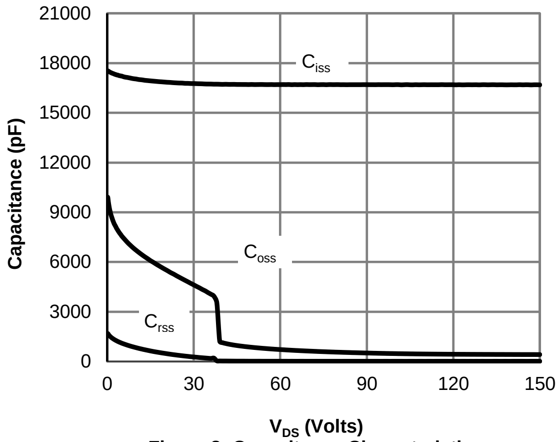


Figure 8: Capacitance Characteristics

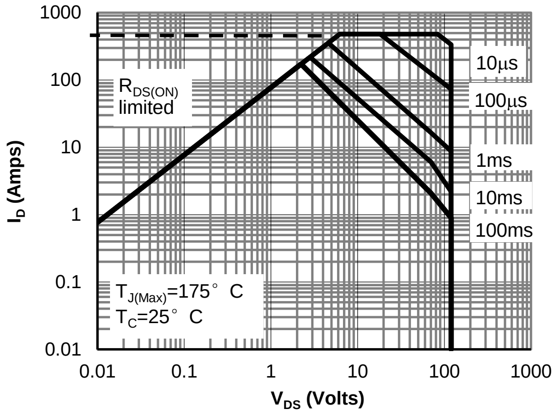


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

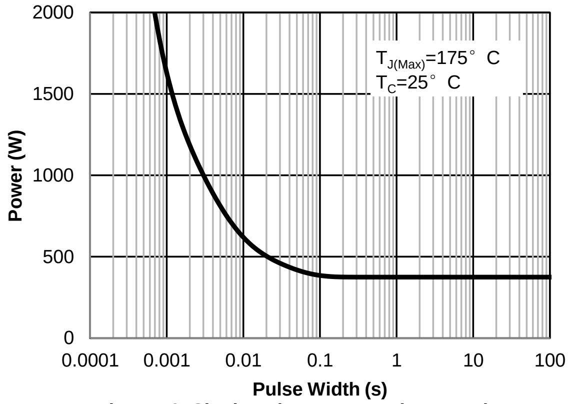


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

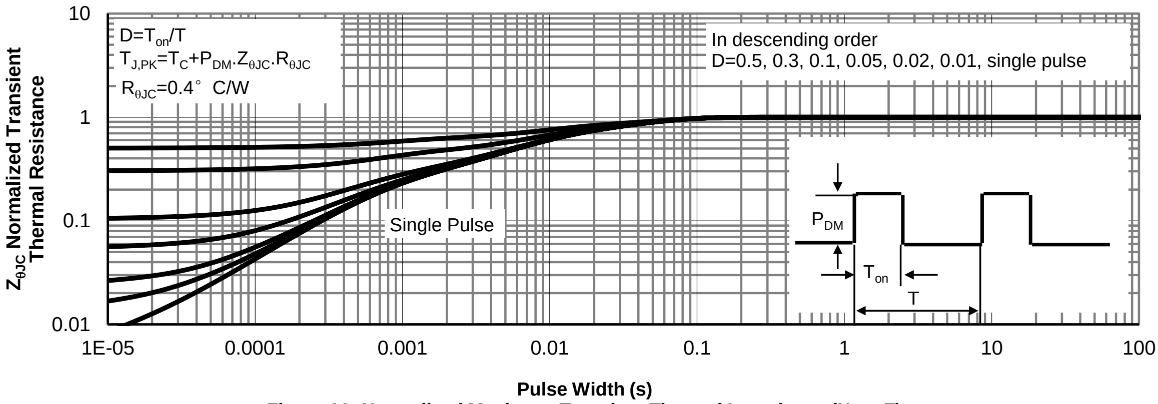


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

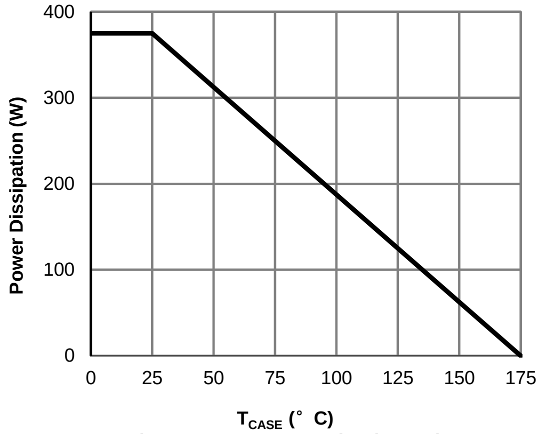


Figure 12: Power De-rating (Note F)

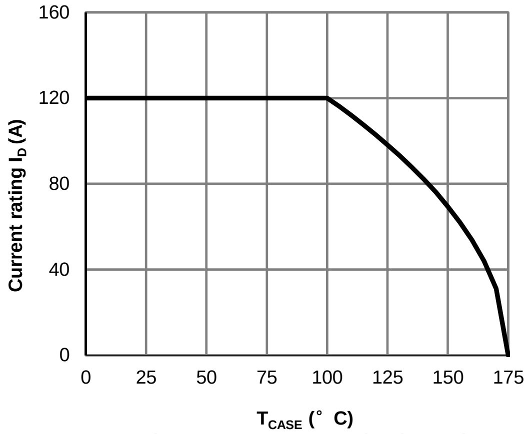


Figure 13: Current De-rating (Note F)

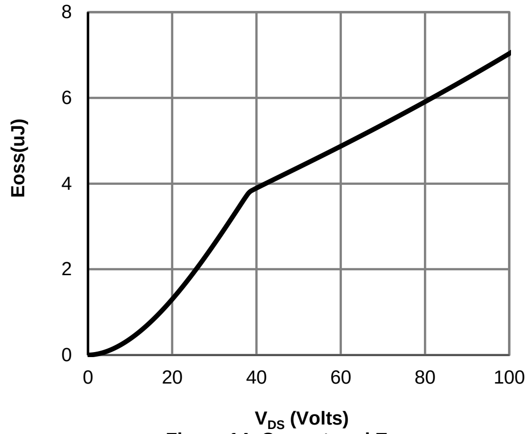


Figure 14: Coss stored Energy

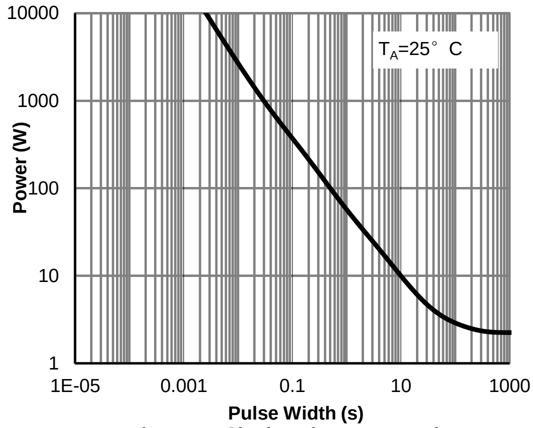


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

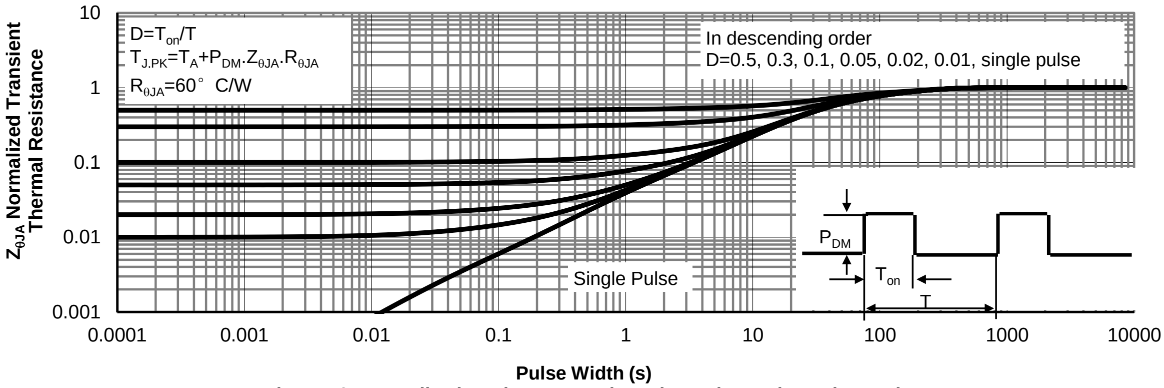


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

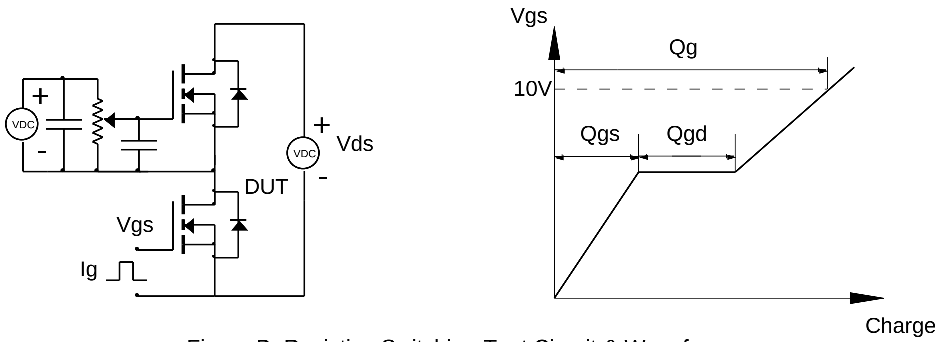


Figure B: Resistive Switching Test Circuit & Waveforms

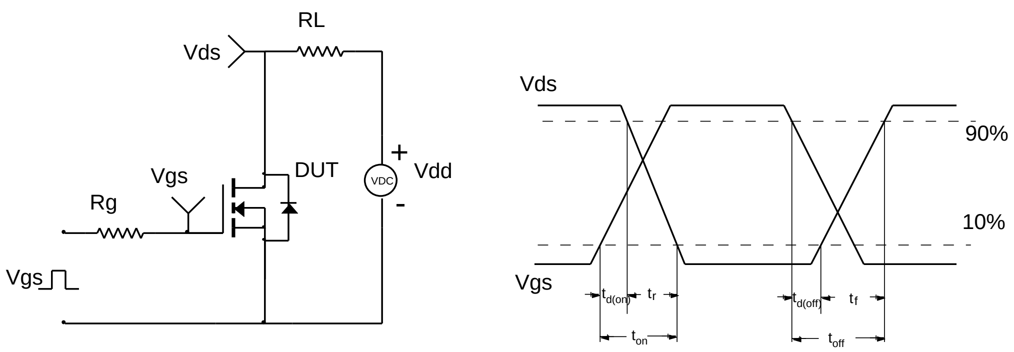


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

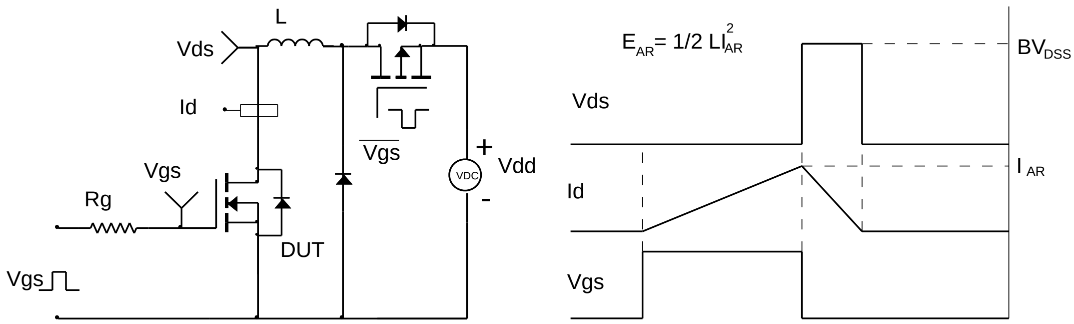


Figure D: Diode Recovery Test Circuit & Waveforms